

<b>Notice of References Cited</b>	Application/Control No. 10/731,246	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Ishwar (I. B.) Patel	Art Unit 2841	Page 1 of 1

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*	B	US-5,764,491	06-1998	Tran, Thanh T.	361/794
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